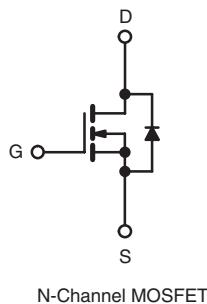
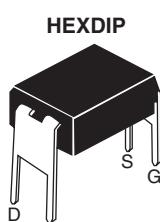


Power MOSFET

PRODUCT SUMMARY	
V _{DS} (V)	400
R _{DS(on)} (Ω)	V _{GS} = 10 V 1.8
Q _g (Max.) (nC)	20
Q _{gs} (nC)	3.3
Q _{gd} (nC)	11
Configuration	Single



FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- For Automatic Insertion
- End Stackable
- Fast Switching
- Ease of Parallelizing
- Simple Drive Requirements
- Lead (Pb)-free Available


RoHS
COMPLIANT

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The 4 pin DIP package is a low cost machine-insertable case style which can be stacked in multiple combinations on standard 0.1" pin centers. The dual drain serves as a thermal link to the mounting surface for power dissipation levels up to 1 W.

ORDERING INFORMATION

Package	HEXDIP
Lead (Pb)-free	IRFD320PbF SiHFD320-E3
SnPb	IRFD320 SiHFD320

ABSOLUTE MAXIMUM RATINGS T_C = 25 °C, unless otherwise noted

PARAMETER	SYMBOL	LIMIT	UNIT
Drain-Source Voltage	V _{DS}	400	V
Gate-Source Voltage	V _{GS}	± 20	
Continuous Drain Current	I _D	0.49	A
		0.31	
Pulsed Drain Current ^a	I _{DM}	3.9	W/°C
Linear Derating Factor		0.0083	
Single Pulse Avalanche Energy ^b	E _{AS}	48	mJ
Avalanche Current ^a	I _{AR}	0.49	A
Repetitive Avalanche Energy ^a	E _{AR}	0.10	mJ
Maximum Power Dissipation	P _D	1.0	W
Peak Diode Recovery dV/dt ^c	dV/dt	4.0	V/ns
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to + 150	°C
Soldering Recommendations (Peak Temperature)	for 10 s	300 ^d	

Notes

- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- V_{DD} = 50 V, starting T_J = 25 °C, L = 21 mH, R_G = 25 Ω, I_{AS} = 2.0 A (see fig. 12).
- I_{SD} ≤ 2.0 A, dI/dt ≤ 40 A/μs, V_{DD} ≤ V_{DS}, T_J ≤ 150 °C.
- 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply

THERMAL RESISTANCE RATINGS

PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R_{thJA}	-	120	°C/W

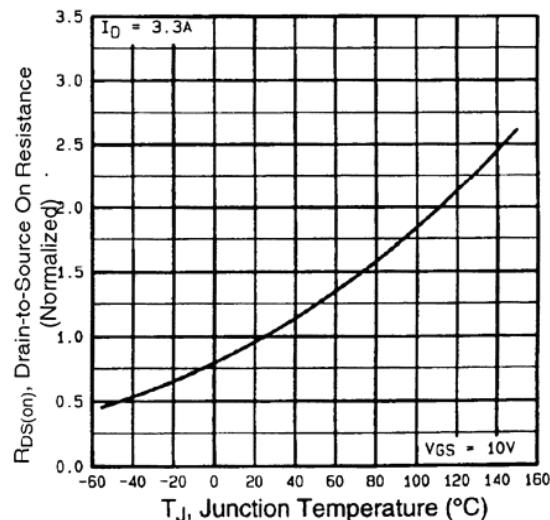
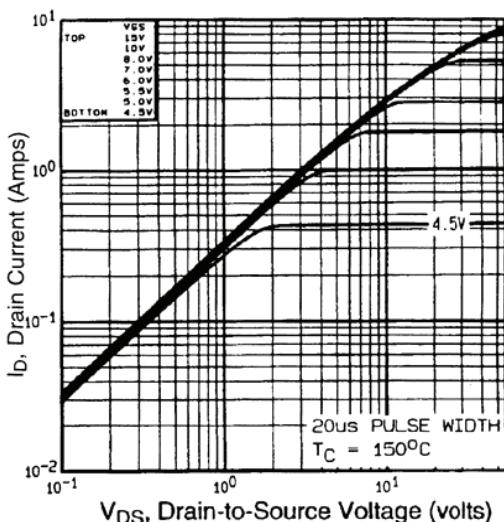
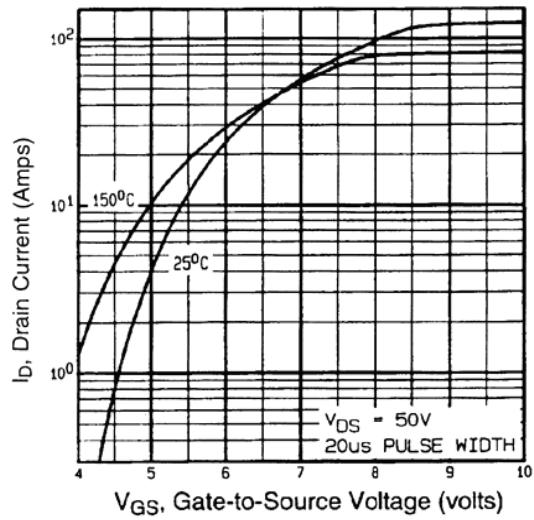
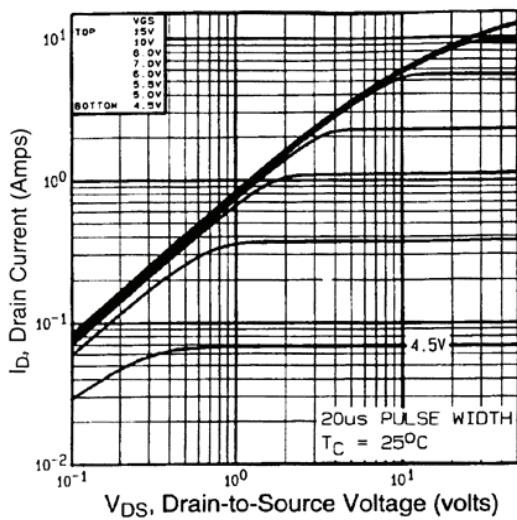
SPECIFICATIONS $T_J = 25^\circ\text{C}$, unless otherwise noted

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT	
Static								
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}$	$I_D = 250 \mu\text{A}$	400	-	-	V	
V_{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference to 25°C , $I_D = 1 \text{ mA}$		-	0.51	-	$^\circ\text{C}/\text{V}$	
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$, $I_D = 250 \mu\text{A}$		2.0	-	4.0	V	
Gate-Source Leakage	I_{GSS}	$V_{GS} = \pm 20 \text{ V}$		-	-	± 100	nA	
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 400 \text{ V}$, $V_{GS} = 0 \text{ V}$		-	-	25	μA	
		$V_{DS} = 320 \text{ V}$, $V_{GS} = 0 \text{ V}$, $T_J = 125^\circ\text{C}$		-	-	250		
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS} = 10 \text{ V}$	$I_D = 0.21 \text{ A}^b$	-	-	1.8	Ω	
Forward Transconductance	g_{fs}	$V_{DS} = 50 \text{ V}$, $I_D = 1.2 \text{ A}$		1.7	-	-	S	
Dynamic								
Input Capacitance	C_{iss}	$V_{GS} = 0 \text{ V}$, $V_{DS} = 25 \text{ V}$, $f = 1.0 \text{ MHz}$, see fig. 5		-	410	-	pF	
Output Capacitance	C_{oss}			-	120	-		
Reverse Transfer Capacitance	C_{rss}			-	47	-		
Total Gate Charge	Q_g	$V_{GS} = 10 \text{ V}$	$I_D = 2.0 \text{ A}$, $V_{DS} = 320 \text{ V}$, see fig. 6 and 13 ^b	-	-	20	nC	
Gate-Source Charge	Q_{gs}			-	-	3.3		
Gate-Drain Charge	Q_{gd}			-	-	11		
Turn-On Delay Time	$t_{d(on)}$			-	10	-		
Rise Time	t_r	$V_{DD} = 200 \text{ V}$, $I_D = 3.3 \text{ A}$, $R_G = 18 \Omega$, $R_D = 56 \Omega$, see fig. 10 ^b		-	14	-	ns	
Turn-Off Delay Time	$t_{d(off)}$			-	30	-		
Fall Time	t_f			-	13	-		
Internal Drain Inductance	L_D			-	4.0	-	nH	
Internal Source Inductance	L_S	Between lead, 6 mm (0.25") from package and center of die contact		-	6.0	-		
Drain-Source Body Diode Characteristics								
Continuous Source-Drain Diode Current	I_S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	0.49	A	
Pulsed Diode Forward Current ^a	I_{SM}			-	-	3.9		
Body Diode Voltage	V_{SD}	$T_J = 25^\circ\text{C}$, $I_S = 0.49 \text{ A}$, $V_{GS} = 0 \text{ V}^b$		-	-	1.6	V	
Body Diode Reverse Recovery Time	t_{rr}	$T_J = 25^\circ\text{C}$, $I_F = 3.3 \text{ A}$, $dI/dt = 100 \text{ A}/\mu\text{s}^b$		-	270	600	ns	
Body Diode Reverse Recovery Charge	Q_{rr}			-	1.4	3.0	μC	
Forward Turn-On Time	t_{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D)						

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width $\leq 300 \mu\text{s}$; duty cycle $\leq 2\%$.

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted


IRFD320, SiHFD320



Vishay Siliconix

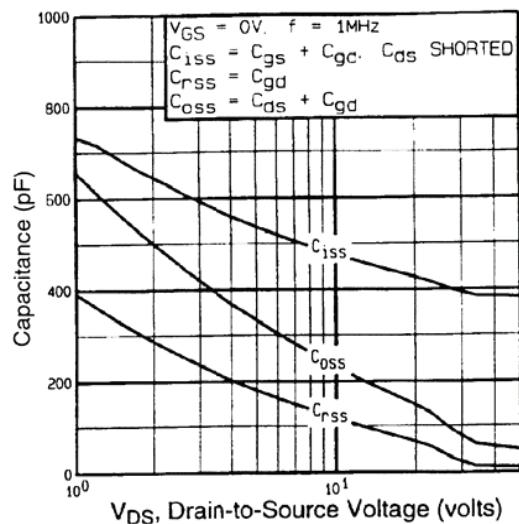


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

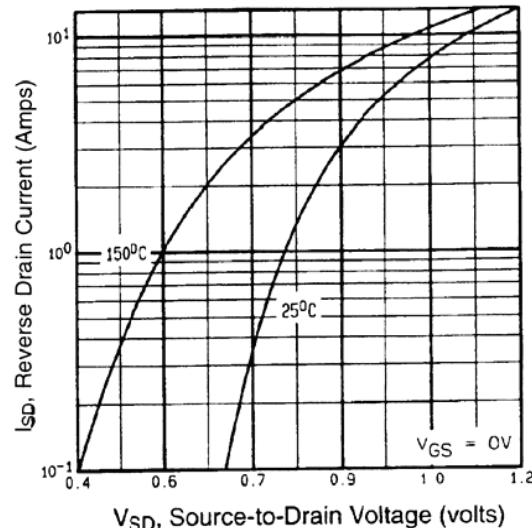


Fig. 7 - Typical Source-Drain Diode Forward Voltage

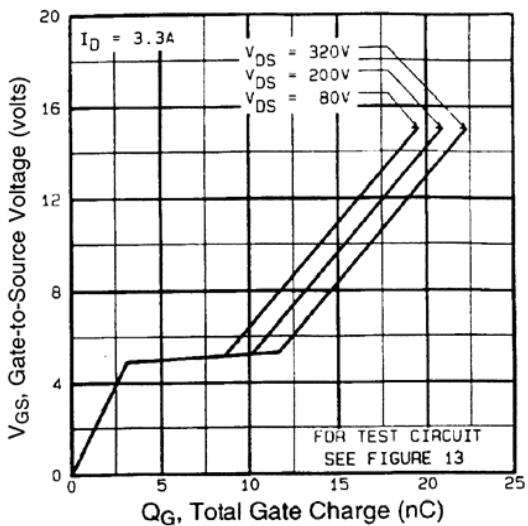


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

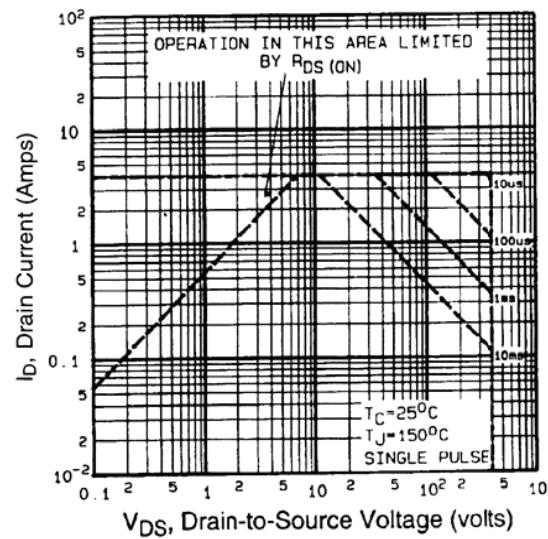


Fig. 8 - Maximum Safe Operating Area

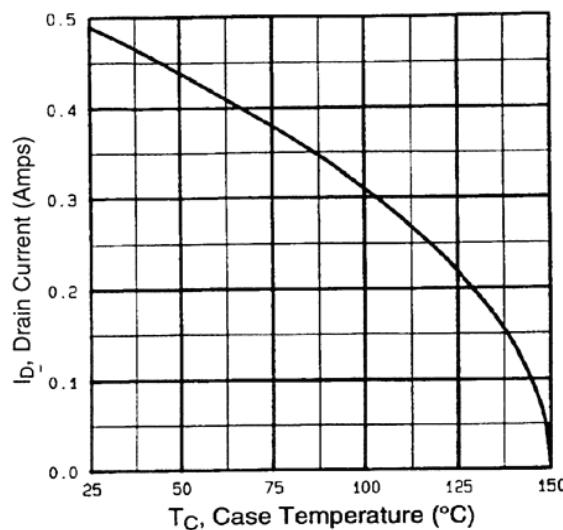


Fig. 9 - Maximum Drain Current vs. Case Temperature

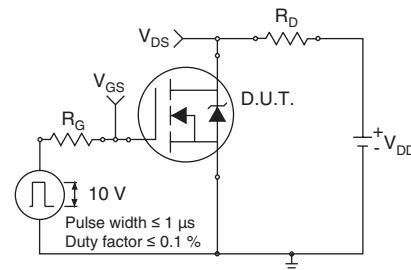


Fig. 10a - Switching Time Test Circuit

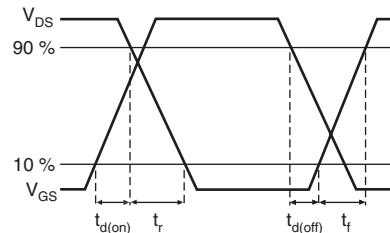


Fig. 10b - Switching Time Waveforms

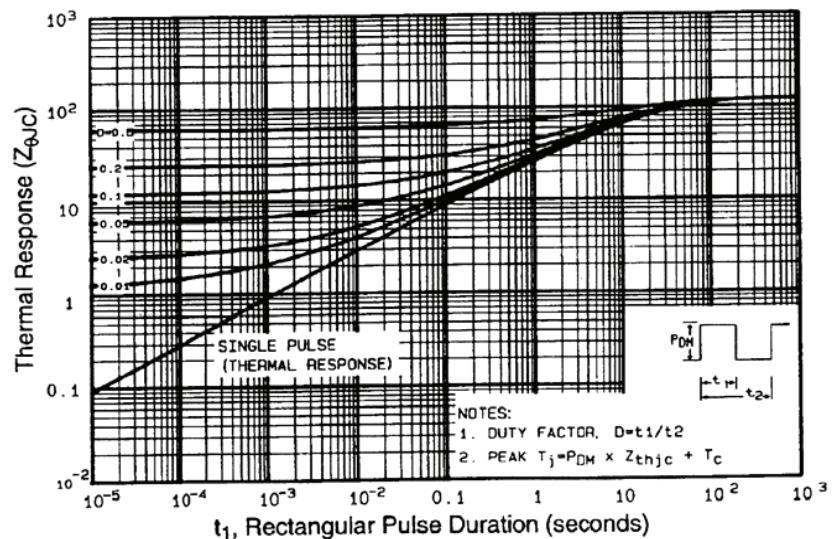


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

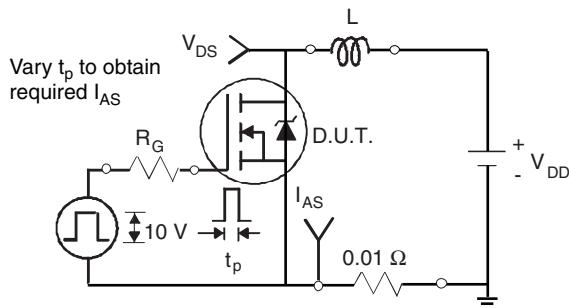


Fig. 12a - Unclamped Inductive Test Circuit

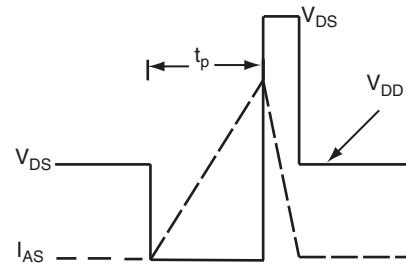


Fig. 12b - Unclamped Inductive Waveforms

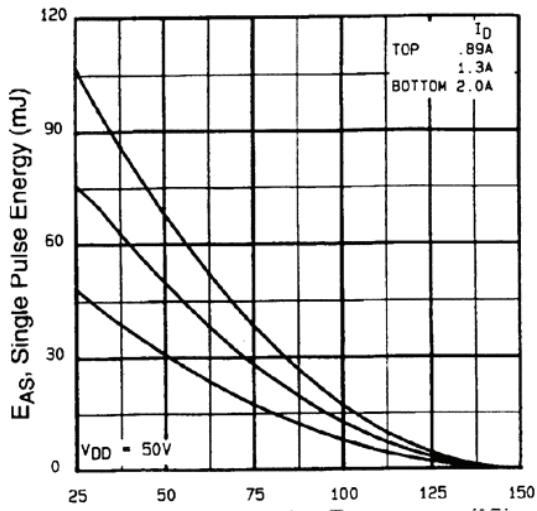


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

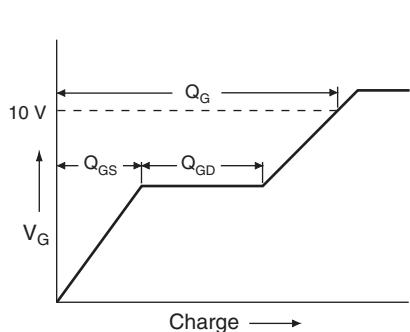


Fig. 13a - Basic Gate Charge Waveform

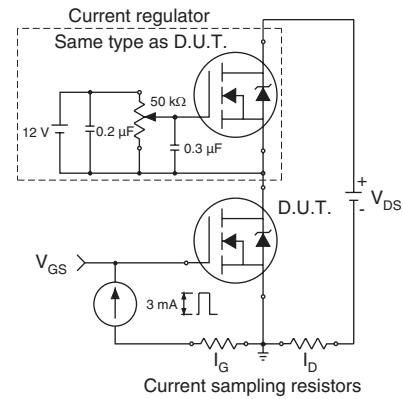
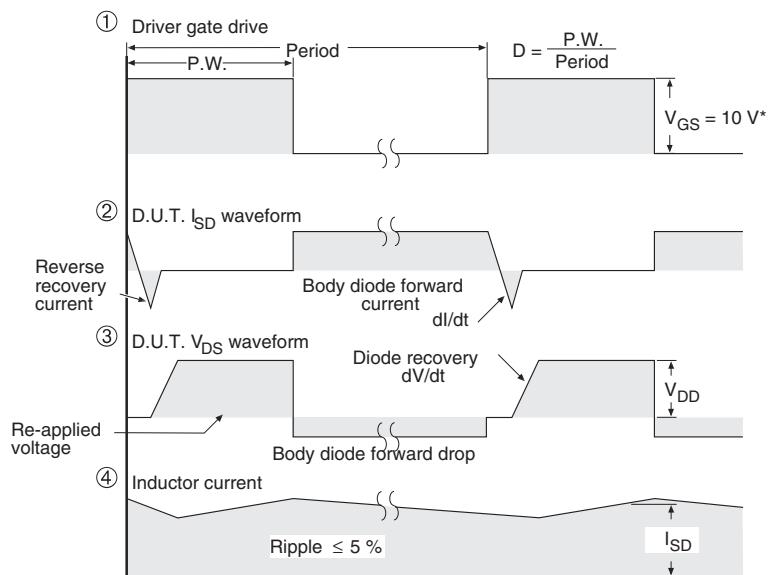
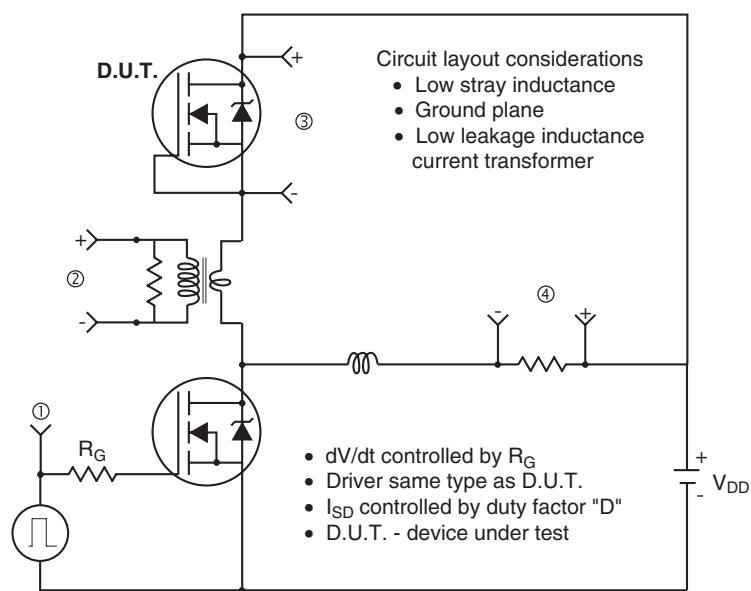


Fig. 13b - Gate Charge Test Circuit

Peak Diode Recovery dV/dt Test Circuit



* $V_{GS} = 5$ V for logic level devices

Fig. 14 - For N-Channel

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